Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/670,610	JAEGER ET AL.
Examiner	Art Unit
Hau H. Nguyen	2676

SEARCHED					
Class	Subclass	Date	Examiner		
345	173,174, 179, 157, 160,161, 184 18.03-18.0	03/06/06	YN.		
178	18-03-18.07 19-01-20-01		b		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search Notes	updated			
345/173,174,179,157, 166,161,184	03/06/66	HN		
178/18.03-18.07,				
19.01 - 20.01				
Consulted with X, Wu and R. Hjerpa	<b>V</b>	V		
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